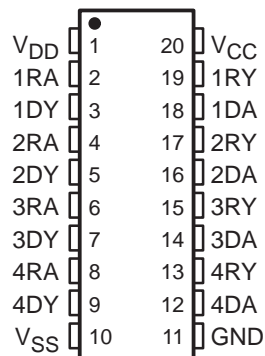


# SN75C1154 QUADRUPLE LOW-POWER DRIVERS/RECEIVERS

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- Meets or Exceeds the Requirements of ANSI EIA/TIA-232-E and ITU Recommendation V.28
- Very Low Power Consumption  
5 mW Typ
- Wide Driver Supply Voltage . . .  $\pm 4.5$  V to  $\pm 15$  V
- Driver Output Slew Rate Limited to 30 V/ $\mu$ s Max
- Receiver Input Hysteresis . . . 1000 mV Typ
- Push-Pull Receiver Outputs
- On-Chip Receiver 1- $\mu$ s Noise Filter
- Functionally interchangeable With Motorola MC145404

DW OR N PACKAGE  
(TOP VIEW)



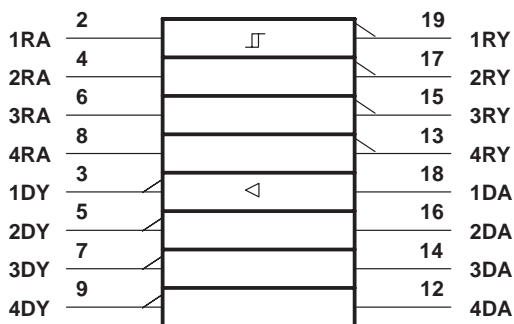
## description

The SN75C1154 is a low-power BiMOS device containing four independent drivers and receivers that are used to interface data terminal equipment (DTE) with data circuit-terminating equipment (DCE). This device has been designed to conform to ANSI EIA/TIA-232-E. The drivers and receivers of the SN75C1154 are similar to those of the SN75C188 quadruple driver and SN75C189A quadruple receiver, respectively. The drivers have a controlled output slew rate that is limited to a maximum of 30 V/ $\mu$ s and the receivers have filters that reject input noise pulses of shorter than 1  $\mu$ s. Both these features eliminate the need for external components.

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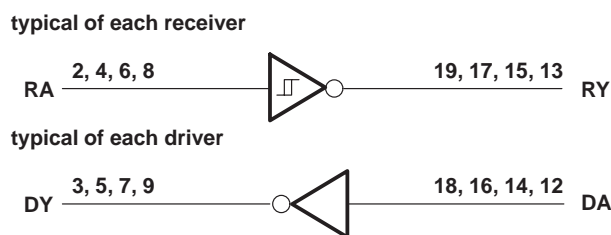
The SN75C1154 is characterized for operation from 0°C to 70°C.

## logic symbol†



† This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

## logic diagram (positive logic)



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PRODUCTION DATA information is current as of publication date. Products conform to specifications per the terms of Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.

**TEXAS  
INSTRUMENTS**

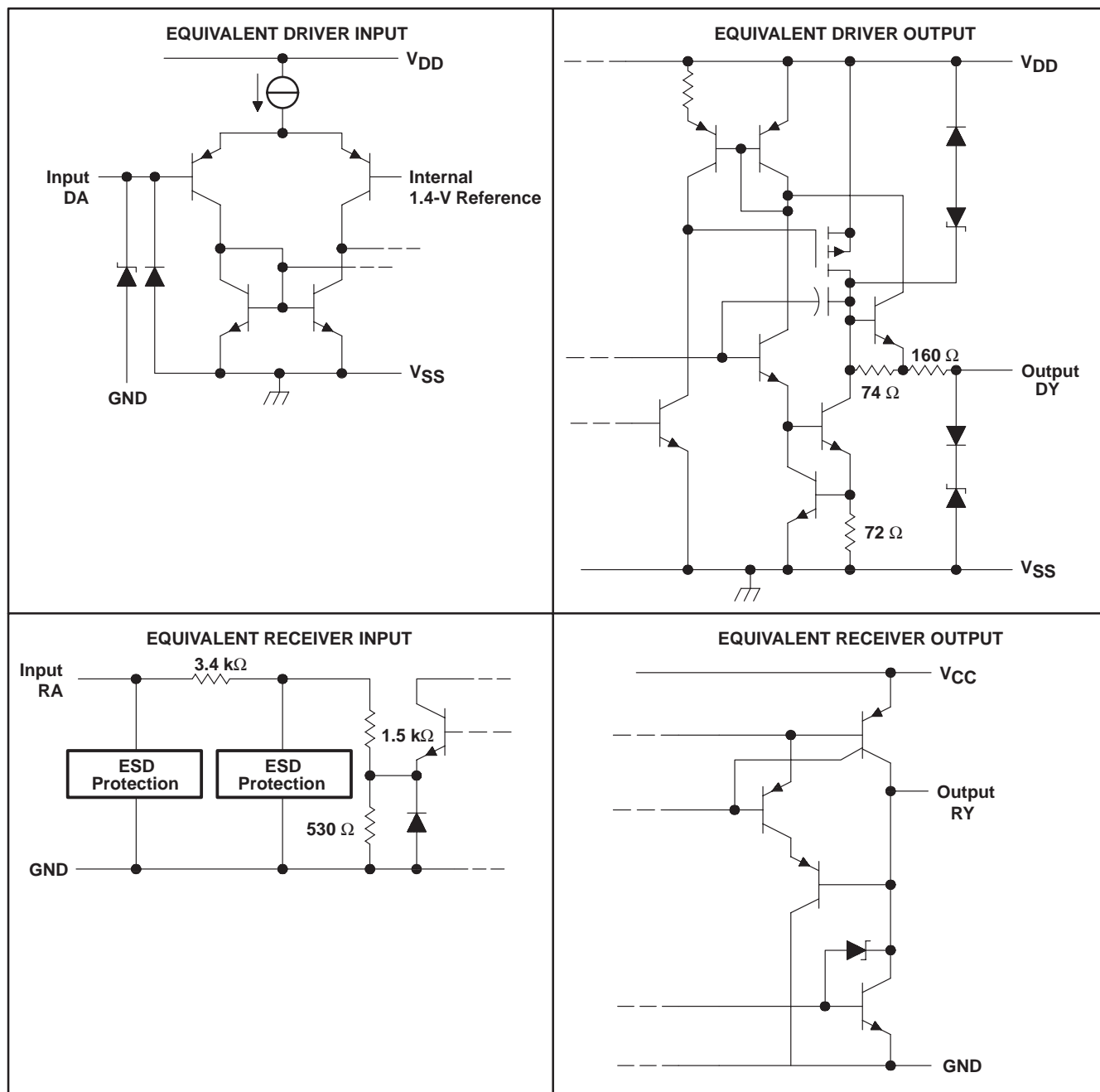
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# SN75C1154 QUADRUPLE LOW-POWER DRIVERS/RECEIVERS

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## schematics of inputs and outputs



Resistor values shown are nominal.

# SN75C1154 QUADRUPLE LOW-POWER DRIVERS/RECEIVERS

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## absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage, $V_{DD}$ (see Note 1)	15 V
Supply voltage, $V_{SS}$	–15 V
Supply voltage, $V_{CC}$	7 V
Input voltage range, $V_I$ : Driver	$V_{SS}$ to $V_{DD}$
Receiver	–30 V to 30 V
Output voltage range, $V_O$ : Driver	( $V_{SS} - 6$ V) to ( $V_{DD} + 6$ V)
Receiver	–0.3 V to ( $V_{CC} + 0.3$ V)
Continuous total power dissipation	See Dissipation Rating Table
Operating free-air temperature range, $T_A$ : SN75C1154	0°C to 70°C
Storage temperature range, $T_{stg}$	–65°C to 150°C
Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds	260°C

† Stresses beyond those listed under “absolute maximum ratings” may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under “recommended operating conditions” is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: All voltages are with respect to the network GND terminal.

**DISSIPATION RATING TABLE**

PACKAGE	$T_A \leq 25^\circ\text{C}$ POWER RATING	DERATING FACTOR ABOVE $T_A = 25^\circ\text{C}$	$T_A = 70^\circ\text{C}$ POWER RATING
DW	1125 mW	9.0 mW/°C	720 mW
N	1150 mW	9.2 mW/°C	736 mW

## recommended operating conditions

		MIN	NOM	MAX	UNIT
Supply voltage, $V_{DD}$		4.5	12	15	V
Supply voltage, $V_{SS}$		–4.5	–12	–15	V
Supply voltage, $V_{CC}$		4.5	5	6	V
Input voltage, $V_I$	Driver	$V_{SS}+2$		$V_{DD}$	V
	Receiver	±25			
High-level input voltage, $V_{IH}$	Driver	2			V
Low-level input voltage, $V_{IL}$		0.8			
High-level output current, $I_{OH}$	Receiver	–1			mA
High-level output current, $I_{OL}$		3.2			mA
Operating free-air temperature, $T_A$		0	70		°C

# SN75C1154

## QUADRUPLE LOW-POWER DRIVERS/RECEIVERS

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### DRIVER SECTION

electrical characteristics over operating free-air temperature range,  $V_{DD} = 12\text{ V}$ ,  $V_{SS} = -12\text{ V}$ ,  $V_{CC} = 5\text{ V} \pm 10\%$  (unless otherwise noted)

PARAMETER		TEST CONDITIONS		MIN	TYP†	MAX	UNIT
V <sub>OH</sub>	High-level output voltage	V <sub>IL</sub> = 0.8 V, See Figure 1	R <sub>L</sub> = 3 kΩ,	V <sub>DD</sub> = 5 V, V <sub>SS</sub> = -5 V	4	4.5	V
				V <sub>DD</sub> = 12 V, V <sub>SS</sub> = -12 V	10	10.8	
V <sub>OL</sub>	Low-level output voltage (see Note 2)	V <sub>IH</sub> = 2 V, See Figure 1	R <sub>L</sub> = 3 kΩ,	V <sub>DD</sub> = 5 V, V <sub>SS</sub> = -5 V	-4.4	-4	V
				V <sub>DD</sub> = 12 V, V <sub>SS</sub> = -12 V	-10.7	-10	
I <sub>IH</sub>	High-level input current	V <sub>I</sub> = 5 V,	See Figure 2			1	μA
I <sub>IL</sub>	Low-level input current	V <sub>I</sub> = 0,	See Figure 2			-1	μA
I <sub>OS(H)</sub>	High-level short circuit output current‡	V <sub>I</sub> = 0.8 V,	V <sub>O</sub> = 0 or V <sub>SS</sub> , See Figure 1	-7.5	-12	-19.5	mA
I <sub>OS(L)</sub>	Low-level short circuit output current‡	V <sub>I</sub> = 2 V,	V <sub>O</sub> = 0 or V <sub>DD</sub> , See Figure 1	7.5	12	19.5	mA
I <sub>DD</sub>	Supply current from V <sub>DD</sub>	No load, All inputs at 2 V or 0.8 V		V <sub>DD</sub> = 5 V, V <sub>SS</sub> = -5 V	115	250	μA
				V <sub>DD</sub> = 12 V, V <sub>SS</sub> = -12 V	115	250	
I <sub>SS</sub>	Supply current from V <sub>SS</sub>	No load, All inputs at 2 V or 0.8 V		V <sub>DD</sub> = 5 V, V <sub>SS</sub> = -5 V	-115	-250	μA
				V <sub>DD</sub> = 12 V, V <sub>SS</sub> = -12 V	-115	-250	
r <sub>o</sub>	Output resistance	V <sub>DD</sub> = V <sub>SS</sub> = V <sub>CC</sub> = 0, V <sub>O</sub> = -2 V to 2 V, See Note 3		300	400		Ω

† All typical values are at T<sub>A</sub> = 25°C.

‡ Not more than one output should be shorted at one time.

NOTES: 2. The algebraic convention, where the more positive (less negative) limit is designated as maximum, is used in this data sheet for logic levels only.

3. Test conditions are those specified by EIA/TIA-232-E.

switching characteristics,  $V_{DD} = 12\text{ V}$ ,  $V_{SS} = -12\text{ V}$ ,  $V_{CC} = 5\text{ V} \pm 10\%$ , T<sub>A</sub> = 25°C

PARAMETER		TEST CONDITIONS		MIN	TYP	MAX	UNIT
t <sub>PLH</sub>	Propagation delay time, low- to high-level output§	R <sub>L</sub> = 3 to 7 kΩ, C <sub>L</sub> = 15 pF, See Figure 3			1.2	3	μs
t <sub>PHL</sub>	Propagation delay time, high- to low-level output§			2.5	3.5	μs	
t <sub>TLH</sub>	Transition time, low- to high-level output¶			0.53	2	3.2	μs
t <sub>THL</sub>	Transition time, high- to low-level output¶			0.53	2	3.2	μs
t <sub>TLH</sub>	Transition time, low- to high-level output#			R <sub>L</sub> = 3 to 7 kΩ, C <sub>L</sub> = 2500 pF, See Figure 3	1	2	μs
t <sub>THL</sub>	Transition time, high- to low-level output#	R <sub>L</sub> = 3 to 7 kΩ, C <sub>L</sub> = 2500 pF, See Figure 3	1	2	μs		
SR	Output slew rate	R <sub>L</sub> = 3 to 7 kΩ, C <sub>L</sub> = 15 pF, See Figure 3	4	10	30	V/μs	

§ t<sub>PHL</sub> and t<sub>PLH</sub> include the additional time due to on-chip slew rate control and are measured at the 50% points.

¶ Measured between 10% and 90% points of output waveform.

# Measured between 3 V and -3 V points of output waveform (EIA/TIA-232-E conditions) with all unused inputs tied either high or low.



# SN75C1154 QUADRUPLE LOW-POWER DRIVERS/RECEIVERS

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## RECEIVER SECTION

**electrical characteristics over operating free-air temperature range,  $V_{DD} = 12\text{ V}$ ,  $V_{SS} = -12\text{ V}$ ,  $V_{CC} = 5\text{ V} \pm 10\%$  (unless otherwise noted)**

PARAMETER		TEST CONDITIONS	MIN	TYP†	MAX	UNIT
$V_{IT+}$	Positive-going input threshold voltage	See Figure 5	1.7	2.1	2.55	V
$V_{IT-}$	Negative-going input threshold voltage	See Figure 5	0.65	1	1.25	V
$V_{hys}$	Input hysteresis voltage ( $V_{IT+} - V_{IT-}$ )		600	1000		mV
$V_{OH}$	High-level output voltage	$V_I = 0.75\text{ V}$ , $I_{OH} = -20\text{ }\mu\text{A}$ , See Figure 5 and Note 4	3.5			V
		$V_I = 0.75\text{ V}$ , $I_{OH} = -1\text{ mA}$ , See Figure 5	$V_{CC} = 4.5\text{ V}$	2.8	4.4	
		$V_{CC} = 5\text{ V}$	3.8	4.9		
		$V_{CC} = 5.5\text{ V}$	4.3	5.4		
$V_{OL}$	Low-level output voltage	$V_I = 3\text{ V}$ , $I_{OL} = 3.2\text{ mA}$ , See Figure 5		0.17	0.4	V
$I_{IH}$	High-level input current	$V_I = 25\text{ V}$	3.6	4.6	8.3	mA
		$V_I = 3\text{ V}$	0.43	0.55	1	
$I_{IL}$	Low-level input current	$V_I = -25\text{ V}$	-3.6	-5	-8.3	mA
		$V_I = -3\text{ V}$	-0.43	-0.55	-1	
$I_{OS(H)}$	Short-circuit output at high level	$V_I = 0.75\text{ V}$ , $V_O = 0$ , See Figure 4		-8	-15	mA
$I_{OS(L)}$	Short-circuit output at low level	$V_I = V_{CC}$ , $V_O = V_{CC}$ , See Figure 4		13	25	mA
$I_{CC}$	Supply current from $V_{CC}$	No load, All inputs at 0 or 5 V	$V_{DD} = 5\text{ V}$ , $V_{SS} = -5\text{ V}$	400	600	$\mu\text{A}$
			$V_{DD} = 12\text{ V}$ , $V_{SS} = -12\text{ V}$	400	600	

† All typical values are at  $T_A = 25^\circ\text{C}$ .

NOTE 4: If the inputs are left unconnected, the receiver interprets this as an input low and the receiver outputs will remain in the high state.

**switching characteristics,  $V_{DD} = 12\text{ V}$ ,  $V_{SS} = -12\text{ V}$ ,  $V_{CC} = 5\text{ V} \pm 10\%$ ,  $T_A = 25^\circ\text{C}$**

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
$t_{PLH}$	Propagation delay time, low- to high-level output	$C_L = 50\text{ pF}$ , $R_L = 5\text{ k}\Omega$ , See Figure 6		3	4	$\mu\text{s}$
$t_{PHL}$	Propagation delay time, high- to low-level output			3	4	$\mu\text{s}$
$t_{TLH}$	Transition time, low- to high-level output			300	450	ns
$t_{THL}$	Transition time, high- to low-level output			100	300	ns
$t_{W(N)}$	Duration of longest pulse rejected as noise‡		$C_L = 50\text{ pF}$ , $R_L = 5\text{ k}\Omega$	1		4

‡ The receiver ignores any positive- or negative-going pulse that is less than the minimum value of  $t_{W(N)}$  and accepts any positive- or negative-going pulse greater than the maximum of  $t_{W(N)}$ .

# SN75C1154 QUADRUPLE LOW-POWER DRIVERS/RECEIVERS

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## PARAMETER MEASUREMENT INFORMATION

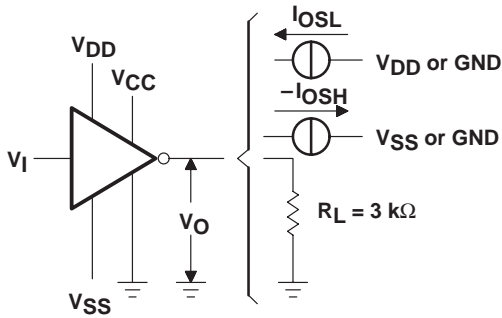


Figure 1. Driver Test Circuit  
 $V_{OH}$ ,  $V_{OL}$ ,  $I_{OSL}$ ,  $I_{OSH}$

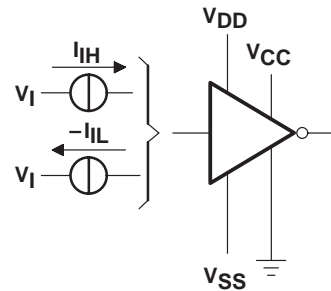
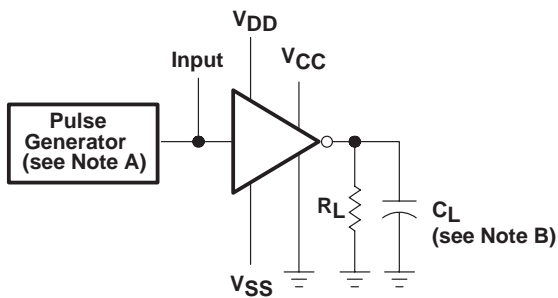
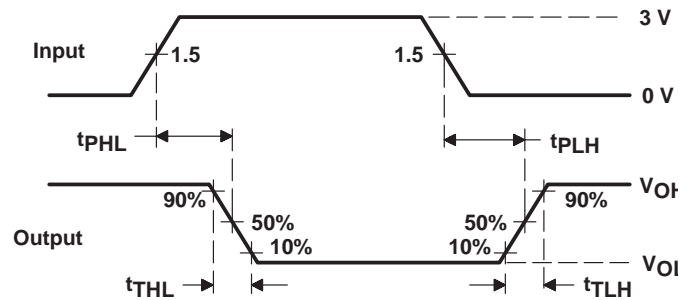


Figure 2. Driver Test Circuit,  $I_{IL}$ ,  $I_{IH}$



TEST CIRCUIT



VOLTAGE WAVEFORMS

- NOTES: A. The pulse generator has the following characteristics:  $t_W = 25 \mu s$ ,  $PRR = 20 \text{ kHz}$ ,  $Z_O = 50 \Omega$ ,  $t_r = t_f < 50 \text{ ns}$ .  
B.  $C_L$  includes probe and jig capacitance.

Figure 3. Driver Test Circuit and Voltage Waveforms

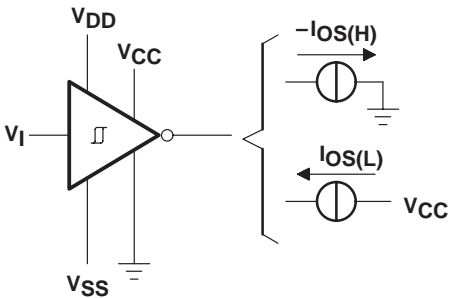


Figure 4. Receiver Test Circuit,  $I_{OSH}$ ,  $I_{OSL}$

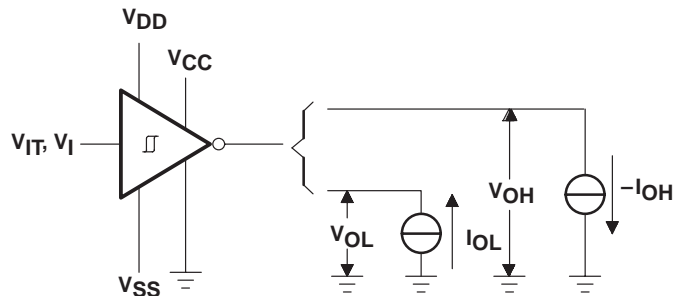
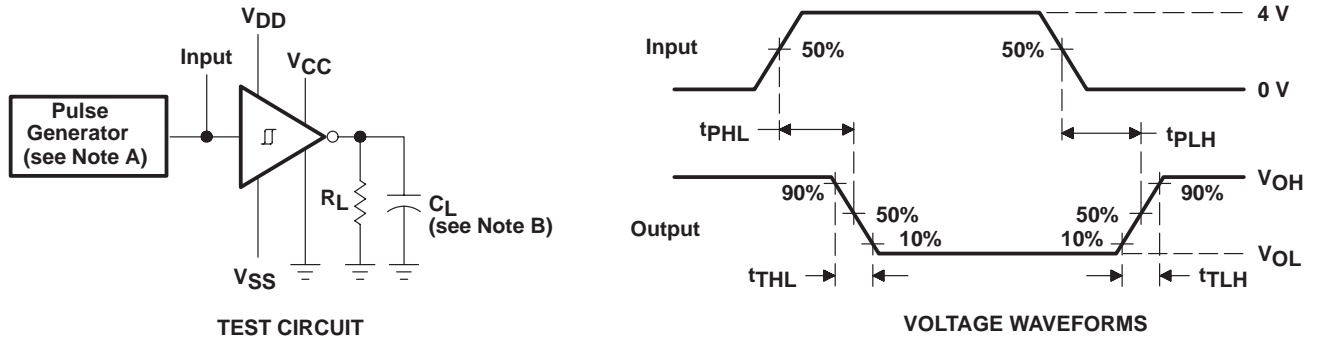


Figure 5. Receiver Test Circuit,  $V_{IT}$ ,  $V_{OL}$ ,  $V_{OH}$

PARAMETER MEASUREMENT INFORMATION



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 B.  $C_L$  includes probe and jig capacitance.

Figure 6. Receiver Test Circuit and Voltage Waveforms

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## SN75C1154, QUADRUPLE LOW-POWER DRIVERS/RECEIVERS

Device Status: Active

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### Description

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The SN75C1154 is characterized for operation from 0°C to 70°C.

### Features

- Meets or Exceeds the Requirements of ANSI EIA/TIA-232-E and ITU Recommendation V.28
- Very Low Power Consumption  
5 mW Typ
- Wide Driver Supply Voltage . . .  $\pm 4.5$  V to  $\pm 15$  V
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- Receiver Input Hysteresis . . . 1000 mV Typ
- Push-Pull Receiver Outputs
- On-Chip Receiver 1-us Noise Filter
- Functionally interchangeable With Motorola MC145404

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## Datasheets

Full datasheet in Acrobat PDF: [slls151c.pdf](#) (139 KB)

Full datasheet in Zipped PostScript: [slls151c.psz](#) (126 KB)

## Pricing/Samples/Availability

Orderable Device	Package	Pins	Temp (°C)	Status	Price/unit USD (100-999)	Pack Qty	Availability / Samples
SN75C1154DW	<a href="#">DW</a>	20	0 TO 70	ACTIVE	1.36	25	<a href="#">Check stock or order</a>
SN75C1154DWR	<a href="#">DW</a>	20	0 TO 70	ACTIVE	1.17	2000	<a href="#">Check stock or order</a>
SN75C1154N	<a href="#">N</a>	20	0 TO 70	ACTIVE	1.36	20	<a href="#">Check stock or order</a>
SN75C1154NS	<a href="#">NS</a>	20	0 TO 70	ACTIVE			<a href="#">Check stock or order</a>

## Application Reports

- [422 AND 485 OVERVIEW AND SYSTEM CONFIGURATIONS](#) (SLLA070 - Updated: 02/15/2000)
- [ANALOG APPLICATIONS JOURNAL, FEBRUARY 2000](#) (SLYT012A - Updated: 03/23/2000)
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